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FCC ID : AK8MEXBT3900
Test report No. : 31AE0021-YK-01-A
Page : 1 of 47
Issued date : August 31, 2010
Revised date : October 26, 2010

RADIO TEST REPORT

Test Report No.: 31AE0021-YK-01-A

Applicant : Sony EMCS Corporation Kisarazu TEC
Type of Equipment : Bluetooth Audio System
Model No. : MEX-BT3900U
FCC ID : AK8MEXBT3900
Test regulation : FCC Part15 Subpart C: 2010
Test result : Complied

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Date of test: August 16, 21, 22, 25 and 26, 2010

**Representative
test engineer:**

Tatsuya Arai
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Approved by :

Go Ishiwata
Assistant Manager of Shonan EMC Lab.

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SECTION 1: Customer information

Company Name : Sony EMCS Corporation Kisarazu TEC
Address : 8-4 Shiomi Kisarazu-shi, Chiba, 292-0834 Japan
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Facsimile Number : +81-438-37-4705
Contact Person : Kengo Nakamura

Sony EMCS Corporation Kisarazu TEC is on behalf of the applicant: Sony corporation.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Bluetooth Audio System
Model Number : MEX-BT3900U
Serial Number : EV-10072
Rating : DC12V
Country of Mass-production : Thailand
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Receipt Date of Sample : August 6, 2010
Modification of EUT : No modification by the test lab.

2.2 Product description

Model: MEX-BT3900U (referred to as the EUT in this report) is a Bluetooth Audio System.

Clock frequency(ies) in the system : 32.768kHz, 4MHz, 7.92MHz, 9MHz, 16.9344MHz, 24MHz

<Radio part>

Equipment type : Transceiver
Frequency of operation : 2402-2480MHz
Bandwidth / Channel spacing : 79MHz&1MHz
Type of modulation : FHSS
Antenna type : Monopole
Antenna connector type : U-FL
Antenna gain : -0.01dBi
ITU code : F1D, G1D
Operation temperature range : -20 to +60 deg.C.

Similar models of the EUT: MEX-BT39UW

This model has the same specification as the EUT.

FCC 15.31 (e)

The equipment provides the Bluetooth transmitter with stable power supply (DC3.3V) ,therefore, the equipment complies with the requirement.

FCC Part 15.203

The equipment and its antenna comply with this requirement since this antenna is built in the equipment and it cannot be replaced by end users.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2010, final revised on January 22, 2010 and effective March 1, 2010
 Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.209 Radiated emission limits, general requirements Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz

3.2 Procedures & Results

Item	Test Procedure	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.4:2003 7. AC powerline conducted emission measurements	FCC Section 15.207	-	N/A *1)	N/A	N/A
Carrier frequency separation	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A		Complied
20dB bandwidth	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)	Conducted	N/A		Complied
Number of hopping frequency	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A	*See data.	Complied
Dwell time	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (a)(1)(iii)	Conducted	N/A		Complied
Maximum peak output power	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (b)(1)	Conducted	N/A		Complied
Band edge compliance & Spurious emission	FCC Public Notice DA 00-705 & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC Section15.247 (d) Section15.209	Conducted/ Radiated	N/A	4.7dB (2400.061MHz, AV, Horizontal, Tx 2441MHz, DH5 / 2400.055MHz, AV, Horizontal, Tx 2480MHz, 3DH5)	Complied
Note: UL Japan's EMI Work Procedures No.QPM05 and QPM15. *1) The test is not appli since the EUT has no AC mains.						

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3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results
Occupied Bandwidth (99%)	ANSI C63.4:2003 13. Measurement of intentional radiators, RSS-Gen 4.6.1 RSS-Gen 4.6.1	RSS-Gen 4.6.1	Conducted	-	Complied

Note: UL Japan's EMI Work Procedures No.QPM05 and QPM15.

* Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC ^{*1} /SR ^{*2} (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Radiated emission (Measurement distance: 3m)	9kHz-30MHz	3.4 dB	2.7 dB	3.4 dB
	30MHz-300MHz	4.6 dB	4.5 dB	4.9 dB
	300MHz-1GHz	4.5 dB	4.6 dB	5.1 dB
	1GHz-13GHz	3.9 dB	3.9 dB	4.0 dB
Radiated emission (Measurement distance: 1m)	13GHz-18GHz	4.8 dB	4.8 dB	4.8 dB
	18GHz-40GHz	4.2 dB	4.2 dB	4.2 dB

*1: SAC=Semi-Anechoic Chamber

*2: SR= Shielded Room is applied besides radiated emission

Radiated emission test

The data listed in this test report has enough margin, more than site margin.

Antenna port conducted test

Power Measurement uncertainty above 1GHz for this test was: (±) 0.8dB

Conducted emissions Measurement (below 1GHz) uncertainty for this test was: (±) 1.1dB

Conducted emissions Measurement (1G-3GHz) uncertainty for this test was: (±) 1.2dB

Conducted emissions Measurement (3G-18GHz) uncertainty for this test was: (±) 2.9dB

Conducted emissions Measurement (18G-26.5GHz) uncertainty for this test was: (±) 3.4dB

Bandwidth Measurement uncertainty for this test was: (±) 5.4%

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3.5 Test location

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JAB Accreditation No. : RTL02610

	FCC Registration No.	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
<input type="checkbox"/> No.1 Semi-anechoic chamber	697847	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input type="checkbox"/> No.2 Semi-anechoic chamber	697847	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input checked="" type="checkbox"/> No.3 Semi-anechoic chamber	697847	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
<input type="checkbox"/> No.4 Full-anechoic chamber	-	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
<input type="checkbox"/> No.1 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.2 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.3 shielded room	-	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
<input type="checkbox"/> No.4 shielded room	-	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
<input checked="" type="checkbox"/> No.5 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
<input type="checkbox"/> No.6 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-

3.6 Test setup, Data of EMI & Test instruments

Refer to Appendix 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

The EUT exercise program used during testing was designed to exercise the various system components in a manner similar to typical use.

Test item	Operating mode	Tested frequency
Carrier frequency separation	Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9	-
20dB bandwidth	Transmitting Hopping OFF (DH5/3DH5)/Inquiry, Payload: PRBS9	2402MHz, 2441MHz, 2480MHz
Number of hopping frequency	Transmitting Hopping ON (DH5/3DH5)/Inquiry, Payload: PRBS9	-
Dwell time	Transmitting (Hopping ON) -DH1, -DH3, -DH5 -3DH1, -3DH3, -3DH5 -Inquiry	-
Maximum peak output power	Transmitting Hopping OFF (DH5/3DH5)/Inquiry, Payload: PRBS9 -DH5 -2DH5 -3DH5	2402MHz, 2441MHz, 2480MHz
Band edge compliance & Spurious emission (Conducted) (Radiated)	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON/Inquiry -Hopping OFF	Band edge compliance: 2402MHz, 2480MHz Spurious emission: 2402MHz, 2441MHz, 2480MHz
99% occupied bandwidth	Transmitting (DH5/3DH5), Payload: PRBS9 -Hopping ON -Hopping OFF	2402MHz, 2441MHz, 2480MHz

*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum payload (except Dwell time test)

*Remarks: Test was not performed at AFH mode, because the decrease of number of channel (min: 20ch) at AFH mode does not influence on the output power and bandwidth of the EUT.
 However, the limit level 125mW of AFH mode was used for the test.

*EUT has the power settings by the software as follows;

Power settings: BDR: Ext.=255, Int.=44
 EDR: Ext.=255, Int.=48

Software: CSR BlueSuite BlueTest Version 1.24
 CSR BlueSuite BtCliCtrl Version 1.24 (Inquiry mode only)

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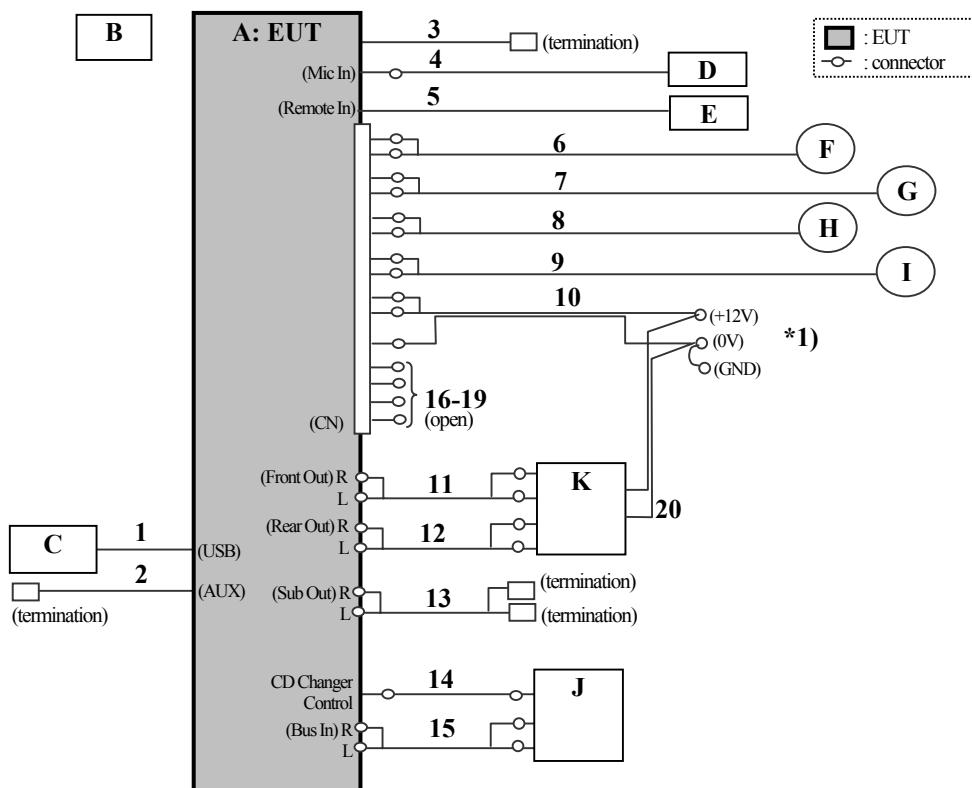
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4.2 Configuration of tested system



* Test data was taken under worse case conditions.

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Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Bluetooth Audio System	MEX-BT3900U	EV-10072	Sony	EUT
B	Remote Controller	RM-X172	-	Sony	-
C	USB Memory	USM64D	B05019AB	Sony	-
D	Microphone	XA-MC10	-	Sony	-
E	Wired Remote Controller	RM-X4S	-	Sony	-
F	Speaker 1	XS-F1611	-	Sony	-
G	Speaker 2	XS-F1611	-	Sony	-
H	Speaker 3	1-544-814-31	-	AIWA	-
I	Speaker 4	1-544-814-31	-	AIWA	-
J	CD changer	CDX-T67	22634	Sony	-
K	Stereo Power Amplifier	XM-423SL	0020316	Sony	-

*1) DC power supply (Model No.: PAN35-10A) was used for DC 12V input.

List of cables used

No.	Cable	Length (m)	Shield-	Shield-Connector	Remarks
1	USB	3.0	Shielded	Shielded	-
2	AUX	3.0	Unshielded	Unshielded	-
3	FM antenna	1.0	Shielded	Shielded	-
4	External Microphone	0.25+4.0	Unshielded	Unshielded	-
5	REMOTE IN	1.9	Unshielded	Unshielded	-
6	Speaker (1)	0.25+2.0	Unshielded	Unshielded	-
7	Speaker (2)	0.25+2.0	Unshielded	Unshielded	-
8	Speaker (3)	0.25+2.0	Unshielded	Unshielded	-
9	Speaker (4)	0.25+2.0	Unshielded	Unshielded	-
10	DC Power	0.2+1.0	Unshielded	Unshielded	-
11	Audio (Front Audio Out)	5.5	Unshielded	Shielded	-
12	Audio (Rear Audio Out)	5.5	Unshielded	Shielded	-
13	Audio (Sub Audio Out)	0.25+2.0	Unshielded	Shielded	-
14	Bus control	5.5	Shielded	Shielded	-
15	Bus Audio IN	5.5	Unshielded	Shielded	-
16	Illumination	0.25	Unshielded	Unshielded	-
17	ANT Control	0.25	Unshielded	Unshielded	-
18	Car telephone	0.25	Unshielded	Unshielded	-
19	Amp Remote	0.25	Unshielded	Unshielded	-
20	DC Power	0.7+0.7	Unshielded	Unshielded	-

* All cables used for the measurement are exclusive use or marketed.

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SECTION 5: Radiated emission

5.1 Operating environment

The test was carried out in No.3 Semi-Anechoic Chamber.

Temperature : See test data (APPENDIX 2)
Humidity : See test data (APPENDIX 2)

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The configuration was set in accordance with ANSI C63.4: 2003. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The rear of EUT, including its peripherals was aligned and flushed with rear of tabletop. I/Os that were connected to the peripherals were bundled in center. They were folded back and for the forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 1.

5.3 Test conditions

Frequency range : 30MHz to 26GHz
Test distance : 3m(below 13GHz) / 1m(above 13GHz)
EUT position : Table top
EUT operation mode : Refer to SECTION 4.1

5.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane and at a distance of 3m(below 13GHz) / 1m(above 13GHz) (Refer to Figure 1). Measurements were performed with quasi-peak, peak and average detector. The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detection of the test receiver.

Frequency	30-1000MHz	1000-26000MHz	
Detection Type	Quasi-Peak	Peak	* Average
IF Bandwidth	120kHz	RBW:1MHz/VBW:1MHz	RBW:1MHz/VBW:10Hz RBW:1MHz/VBW:300Hz *1)

*1) Used for the band edge of the carrier and the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (Refer to page 33, 34).

* When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

The EUT was tested in the direction normally used.

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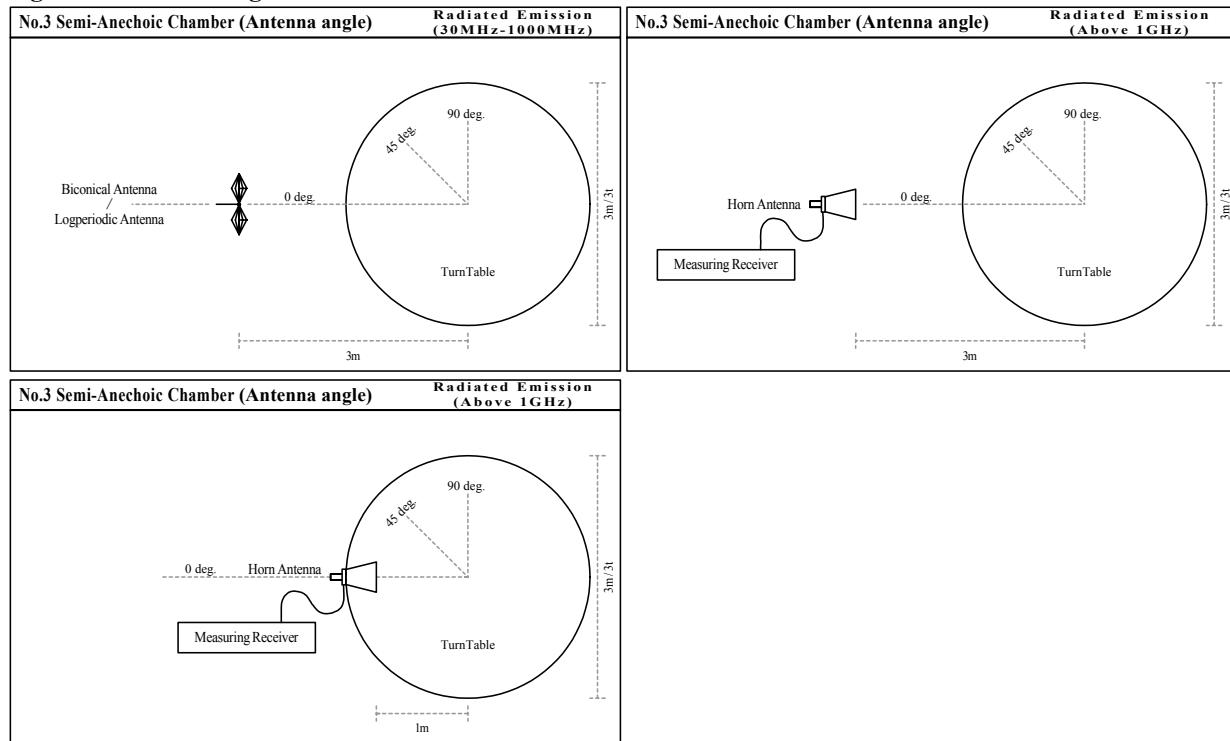
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Figure 1. Antenna angle



5.5 Band edge

Band edge level at 2390MHz, 2400MHz and 2483.5MHz is below the limits of FCC 15.209. Refer to the data of Radiated emission.

5.6 Results

Summary of the test results : Pass *No noise was detected above the 5th order harmonics.
 Refer to APPENDIX 2

SECTION 6: Out of band emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port. In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 7: Carrier frequency separation

Test procedure

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 8: 20dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
The channel separation in Hopping mode and Inquiry mode was separated by 25kHz and 2/3 of the 20dB bandwidth.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 9: Number of hopping frequency

Test procedure

The Number of Hopping Frequency was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 10: Dwell time

Test procedure

The Dwell time was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

SECTION 11: Maximum peak output power

Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

Summary of the test results: Pass
Refer to APPENDIX 2

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